



Varian TV-70, TV-70D, TV-70LP

Technical Specifications

Pump Specification	Turbo-V 70		Turbo-V 70 D		Turbo-V 70 LP	
	DN 40	DN 63	DN 40	DN 63	DN 40	DN 63
Pumping Speed, l/s						
Nitrogen	46	68	40	60	46	68
Helium	52	60	27	30	52	60
Hydrogen	42	45	20	20	42	45
Compression Ratio						
Nitrogen	5×10^7	5×10^7	5×10^7	5×10^7	5×10^8	5×10^8
Helium	4×10^3	4×10^3	7×10^3	7×10^3	8×10^4	8×10^4
Hydrogen	4×10^2	4×10^2	1.5×10^3	1.5×10^3	1×10^4	1×10^4
Base pressure, mbar						
with recommended mechanical pump	1×10^{-9}	1×10^{-9}	$< 1 \times 10^{-9}$	$< 1 \times 10^{-9}$	$< 2 \times 10^{-10}$	$< 2 \times 10^{-10}$
with recommended dry pump	N/A	N/A	$< 1 \times 10^{-8}$	$< 1 \times 10^{-8}$	$< 2 \times 10^{-9}$	$< 2 \times 10^{-9}$
Startup Time, min						
	< 1	< 1	< 1	< 1	< 1	< 1
Rotational Speed, rpm						
	75,000	75,000	75,000	75,000	75,000	75,000
Recommended Forepump						
Two-stage mechanical pump	DS 102	DS 102	DS 102	DS 102	DS 102	DS 102
Dry pump	N/A	N/A	SH-100	SH-100	SH-100	SH-100
Inlet Flange, nominal diameter						
Klamp Flange, mm	40	-	40	-	40	-
ConFlat®, mm (inches OD)	35 (2.75)	63 (4.5)	35 (2.75)	63 (4.5)	35 (2.75)	63 (4.5)
ISO clamp style, mm	-	63	-	63	-	63
Foreline Flange, nominal diameter						
Wheeler, inches ID	-	-	-	-	-	-
Klamp Flange	NW16	NW16	NW16	NW16	NW16	NW16
ISO clamp style	-	-	-	-	-	-

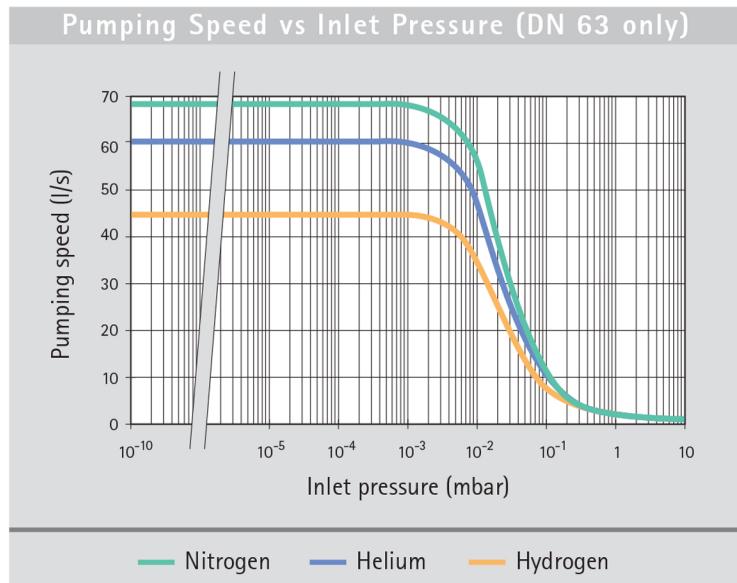


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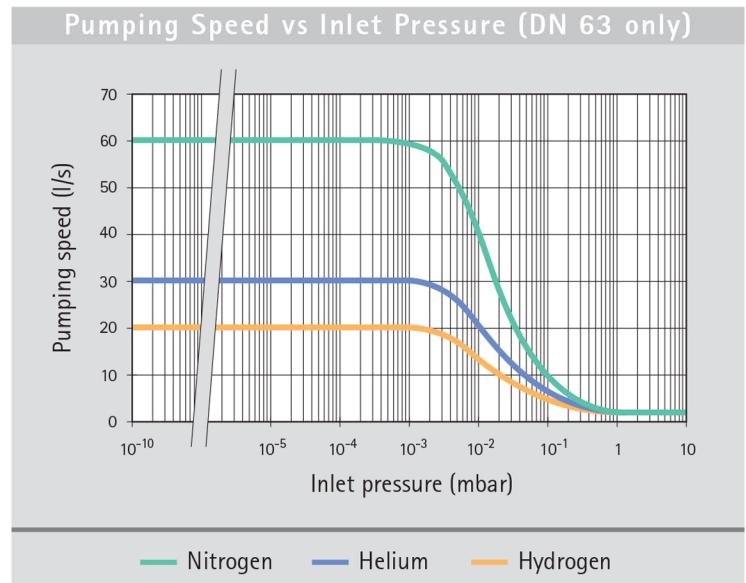
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Varian TV-70, TV-70D, TV-70LP Pumping Curves

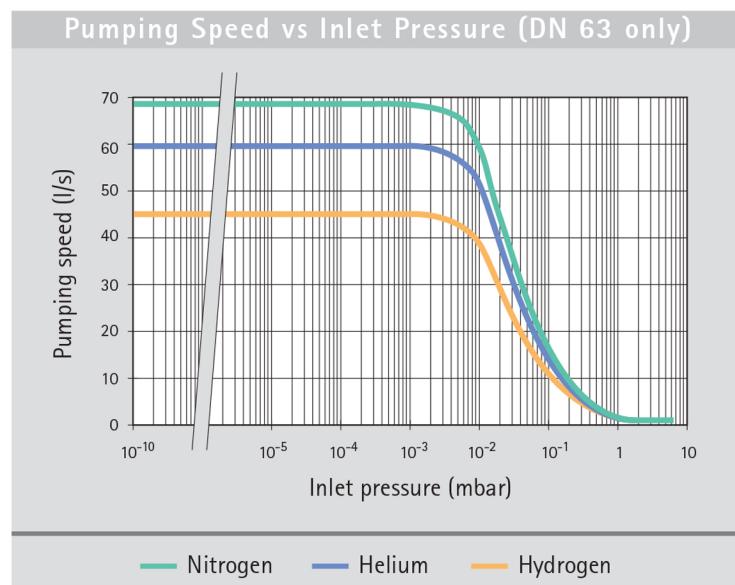
TV-70



TV-70D



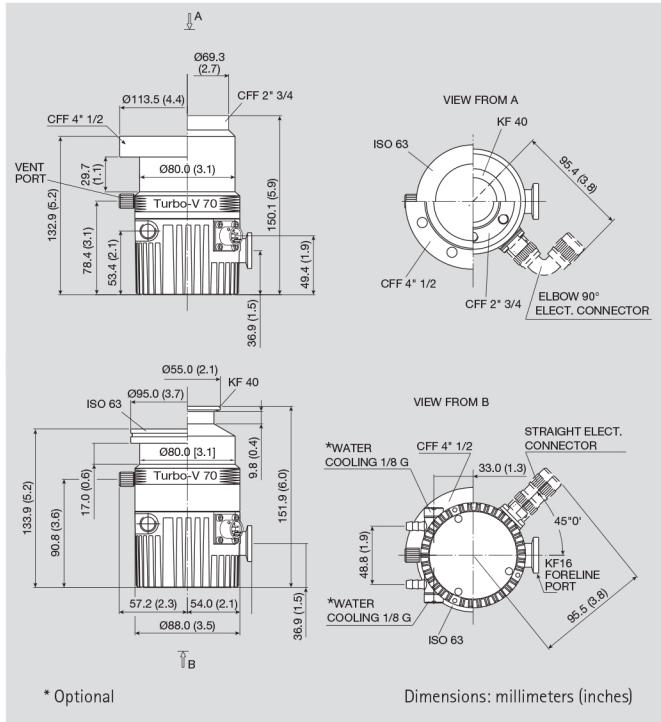
TV-70LP



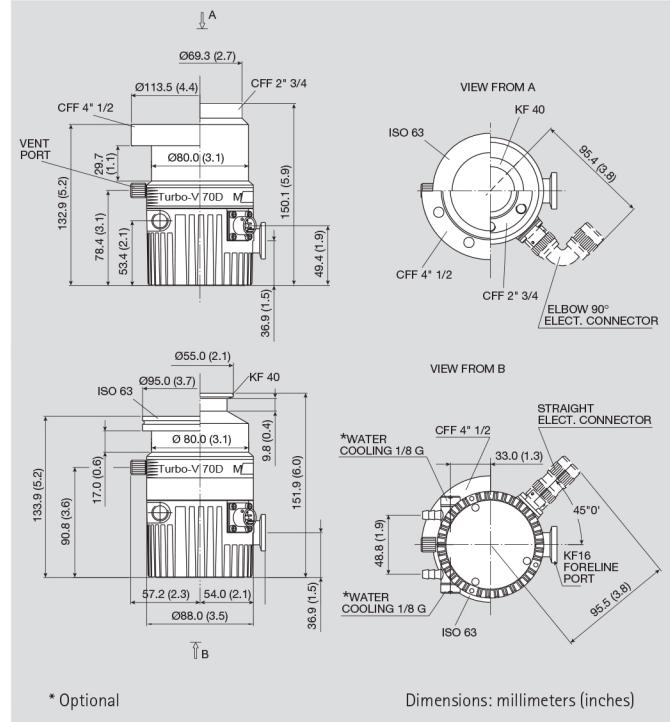


Varian TV-70, TV-70D, TV-70LP Dimensions

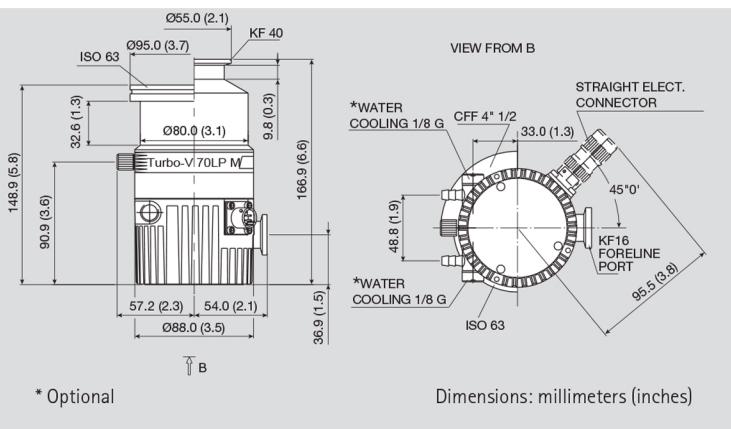
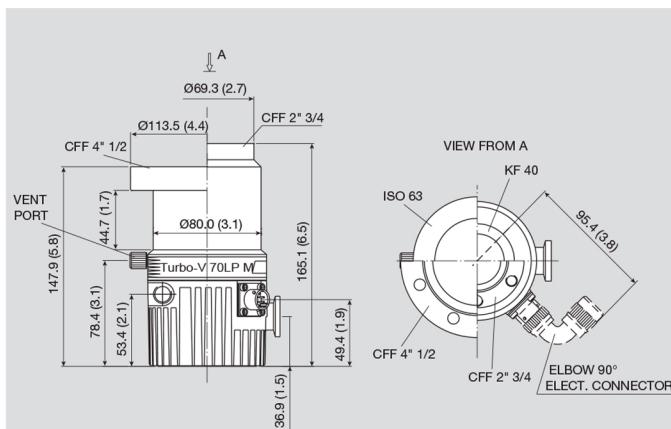
TV-70



Tv-70D



TV-70LP





Varian TV-70, TV-70D, TV-70LP

Features & Benefits

- wide pumping speed range
- high speed and compression
- designed for very high gas load operation
- monolithic rotor
- highly reliable, maintenance-free ceramic ball bearings
- very high foreline tolerance

Applications

- semiconductors • high energy physics • research laboratories • fusion technology • UHV research • analytical instrumentation • electron microscopy • focused ion beam systems • surface analysis